

Notice of References Cited	Application/Control No. 10/003,482	Applicant(s)/Patent Under Reexamination UR ET AL.	
	Examiner J. Derek Rutten	Art Unit 2192	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
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NON-PATENT DOCUMENTS

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	W	Marre and Bertolino, "Reducing and estimating the cost of test coverage criteria", 1996, Proceedings of the 18 th international conference on Software engineering (ICSE-18), ISBN: 0-8186-7246-3, pages 486-494
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.